

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/711,797	TSENG, HUNG-CHANG	
Examiner		Art Unit		Page 1 of 1
Lisa Lea-Edmonds		2835		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0141181	06-2005	Stephany et al.	361/681
*	B	US-7,110,248	09-2006	Weng et al.	361/681
*	C	US-6,744,623	06-2004	Numano et al.	361/681
*	D	US-6,404,623	06-2002	Koshika, Fumihito	361/681
*	E	US-6,013,878	01-2000	Schwartz et al.	177/25.13
*	F	US-5,640,297	06-1997	Labaze, Ducarmel	361/683
*	G	US-6,557,812	05-2003	Kutzehr et al.	248/476
*	H	US-6,295,883	10-2001	Tsukada et al.	74/89.18
*	I	US-6,137,676	10-2000	Merkel, Harold S.	361/680
*	J	US-7,040,697	05-2006	Tuccinardi et al.	297/217.3
*	K	US-2003/0105892	06-2003	Numano et al.	710/14
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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